

FORM PTO-1449		SERIAL NO. 10/583,622	CASE NO. 9683/266
LIST OF PATENTS AND PUBLICATIONS FOR APPLICANT'S INFORMATION DISCLOSURE STATEMENT		FILING DATE April 23, 2007	GROUP ART UNIT 2617
(use several sheets if necessary)	APPLICANT(S): Satoshi Washio et al.		CONFIRMATION NO. 5916

REFERENCE DESIGNATION
U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
	B1	5,282,247	01/25/1994	McLean et al.	380/4	11/12/1992
	B2	5,933,773	08/03/1999	Barvesten	455/411	05/12/1997
	B3	6,047,071	04/04/2000	Shah	380/273	04/15/1997
	B4	6,091,946	07/18/2000	Ahvenainen	455/411	06/20/1997
	B5	6,173,172 B1	01/09/2001	Masuda et al.	455/410	11/26/1997
	B6	6,212,372 B1	04/03/2001	Julin	455/418	01/09/1997
	B7	6,236,859 B1	05/22/2001	Morper	455/435	03/15/1999
	B8	6,314,409 B2	11/06/2001	Schneck et al.	705/54	10/26/1998
	B9	6,320,947 B1	11/20/2001	Joyce et al.	379/144	09/14/1999
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	B11	6,381,316 B2	04/30/2002	Joyce et al.	379/114.2	05/09/2001
	B12	6,445,914 B1	09/03/2002	Findikli et al.	455/411	09/08/1999
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	B15	6,810,479 B1	10/26/2004	Barlow et al.	713/185	01/26/2000
	B16	6,871,063 B1	03/22/2005	Schiffer	455/410	06/30/2000
	B17	6,975,855 B1	12/13/2005	Wallenius	455/417	01/15/2002
	B18	6,999,948 B1	02/14/2006	Hatanaka et al.	705/65	02/14/2006
	B19	7,130,648 B1	10/31/2006	Fournier et al.	455/466	06/18/2001
	B20	7,248,886 B1	07/24/2007	Ljungstroem et al.	455/465	01/19/2000
	B21	7,349,697 B2	03/25/2008	Onaka et al.	455/435.1	07/12/2001
	B22	2002/0099665 A1	07/25/2002	Burger et al.	705/67	10/01/2001
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EXAMINER INITIAL		DOCUMENT NUMBER <small>Number-Kind Code (if known)</small>	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
	B24	JP H08-065740	03/08/1996	JP	H04Q 7/38	Abstract
	B25	JP H09-023268	01/21/1997	JP	H04M 1/65	Yes
	B26	EP 0 607 767 B1	11/26/1997	EPO	G07F 7/10	
	B27	WO 97/44762 A1	11/27/1997	WIPO	G07F 7/10	Abstract
	B28	JP H09-322239	12/12/1997	JP	H04Q 7/38	US6,173,172
	B29	JP H11-191804	07/13/1999	JP	H04M 1/66	Yes
	B30	JP H11-306118	11/05/1999	JP	G06F 13/00	Abstract
	B31	WO 99/57843 A1	11/11/1999	WIPO	H04L 9/00	
	B32	JP 2000-049687	02/18/2000	JP	H04B 7/26	Abstract
	B33	JP 2000-099187	04/07/2000	JP	G06F 1/00	Abstract
	B34	WO 00/48416 A1	08/17/2000	WIPO	H04Q 7/32	

EXAMINER	DATE CONSIDERED
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	B35	WO 00/59225 A1	10/05/2000	WIPO	H04N 7/167	
	B36	EP 1 047 277 A2	10/25/2000	EPO	H04Q 7/32	
	B37	EP 1 085 395 A2	03/21/2001	EPO	G06F 1/00	
	B38	KR 2001-0043378	05/25/2001	KR	H04Q 7/38	WO 99/57843
	B39	EP 1 107 627 A1	06/13/2001	EPO	H04Q 7/32	
	B40	EP 1 143 688 A1	10/10/2001	EPO	H04M 1/247	
	B41	JP 2002-100116 A	04/05/2002	JP	G11B 20/10	Yes
	B42	JP 2002-135407 A	05/10/2002	JP	H04M 1/673	Yes

OTHER ART – NON PATENT LITERATURE DOCUMENTS

EXAMINER INITIAL	(Include name of author, title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date page(s), volume-issue number(s), publisher, city and/or country where published.	
	B43	Microsoft Outlook 98, http://support.microsoft.com/?kbid=181005 , 2 pages of English version, 3 pages of Japanese version, July 30, 2001.
	B44	Japanese Office Action dated September 11, 2007, issued in Japanese Patent Application No. 2001-392068, with English translation, 5 pages.

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